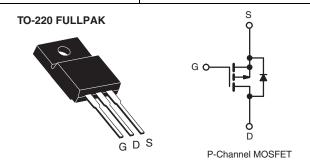


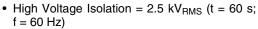
Power MOSFET

PRODUCT SUMMARY			
V _{DS} (V)	- 60		
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = - 10 V	0.28	
Q _g (Max.) (nC)	19		
Q _{gs} (nC)	5.4		
Q _{gd} (nC)	11		
Configuration	Single		



FEATURES

Isolated Package





RoHS*

- Sink to Lead Creepage Distance = 4.8 mm
- P-Channel
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION			
Package	TO-220 FULLPAK		
Load (Dh) free	IRFI9Z24GPbF		
Lead (Pb)-free	SiHFI9Z24G-E3		
SnPb	IRFI9Z24G		
SILL	SiHFI9Z24G		

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, ur	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	- 60	v	
Gate-Source Voltage			V_{GS}	± 20	1 v	
Continuous Drain Current	V _{GS} at - 10 V	T _C = 25 °C	1	- 8.5	А	
	V _{GS} at - 10 V	T _C = 100 °C	ID	- 6.0		
Pulsed Drain Current ^a			I _{DM}	- 34		
Linear Derating Factor				0.24	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	200	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 8.5	Α	
Repetitive Avalanche Energy ^a			E _{AR}	3.7	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	37	W	
Peak Diode Recovery dV/dtc			dV/dt	- 4.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for 1	0 s	-	300 ^d		
Mounting Torque	6 22 or M	C 00 av M0 aava		10	lbf ⋅ in	
	6-32 or M3 screw			1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = -25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 3.2 \,^{\circ}\text{MH}$, $R_G = 25 \,^{\circ}\Omega$, $I_{AS} = -8.5 \,^{\circ}\text{A}$ (see fig. 12).
- c. $I_{SD} \le$ 11 A, $dI/dt \le$ 140 A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le$ 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFI9Z24G, SiHFI9Z24G

Vishay Siliconix

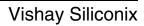


THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	4.1	C/VV	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	- 60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = -1 mA			-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V _{DS} = V _{GS} , I _D = - 250 μA		-	- 4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V		-	± 100	nA
Zerra Octa Wallana D. C. C.		V _{DS} =	V _{DS} = - 60 V, V _{GS} = 0 V		-	- 100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 48	V _{GS} = 0 V, T _J = 150 °C	-	-	- 500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 5.1 A ^b	-	-	0.28	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	- 25 V, I _D = - 5.1 A ^b	3.2	-	-	S
Dynamic					•		
Input Capacitance	C _{iss}	V _{GS} = 0 V,		-	570	-	
Output Capacitance	C _{oss}		$V_{DS} = -25 \text{ V},$		360	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	65	-	pF
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Qg		I _D = - 11 A, V _{DS} = - 48 V, see fig. 6 and 13 ^b	-	-	19	nC
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V		-	-	5.4	
Gate-Drain Charge	Q _{gd}	1		-	-	11	
Turn-On Delay Time	t _{d(on)}				13	-	- ns
Rise Time	t _r	$V_{DD} = -30 \text{ V}, I_{D} = -11 \text{ A},$ $R_{G} = 18 \Omega, R_{D} = 2.5 \Omega,$ see fig. 10^{b}		-	68	-	
Turn-Off Delay Time	t _{d(off)}			-	15	-	
Fall Time	t _f			-	29	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s	-					
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 8.5	- A
Pulsed Diode Forward Current ^a	I _{SM}			ı	-	- 34	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = -8.5 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	- 6.3	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = -11 A, dl/dt = 100 A/μs ^b			100	200	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.32	0.64	μС
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

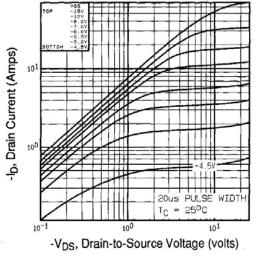


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

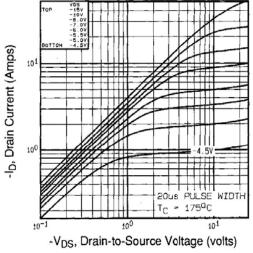


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

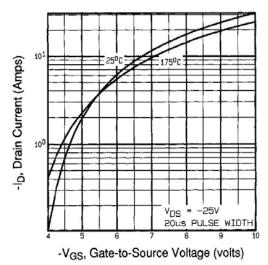


Fig. 3 - Typical Transfer Characteristics

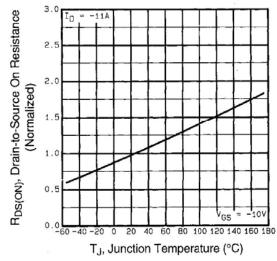


Fig. 4 - Normalized On-Resistance vs. Temperature



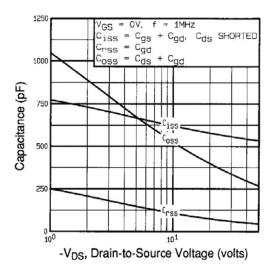


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

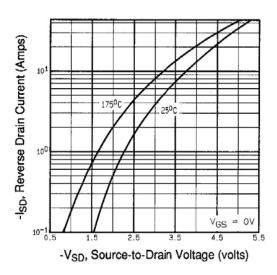


Fig. 7 - Typical Source-Drain Diode Forward Voltage

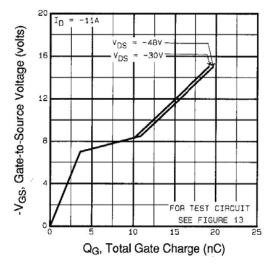


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

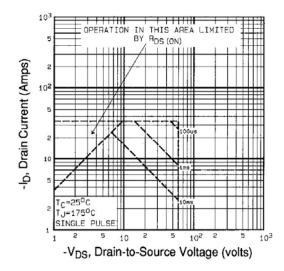


Fig. 8 - Maximum Safe Operating Area

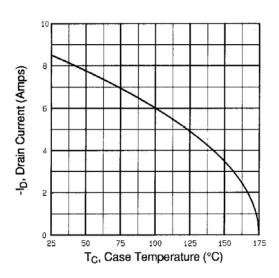


Fig. 9 - Maximum Drain Current vs. Case Temperature

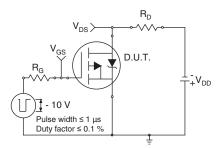


Fig. 10a - Switching Time Test Circuit

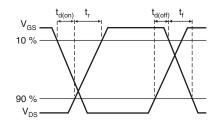


Fig. 10b - Switching Time Waveforms

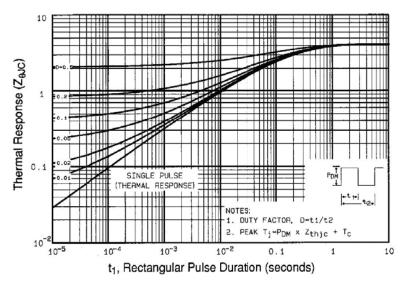


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

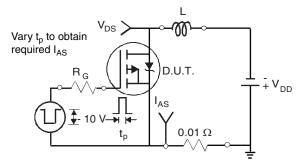


Fig. 12a - Unclamped Inductive Test Circuit

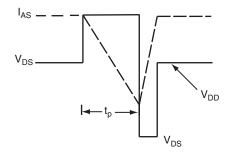


Fig. 12b - Unclamped Inductive Waveforms



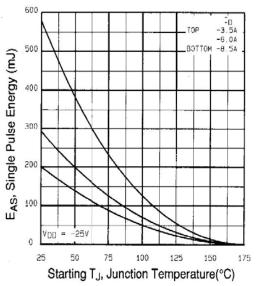


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

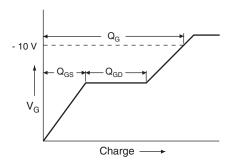


Fig. 13a - Basic Gate Charge Waveform

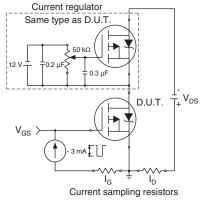
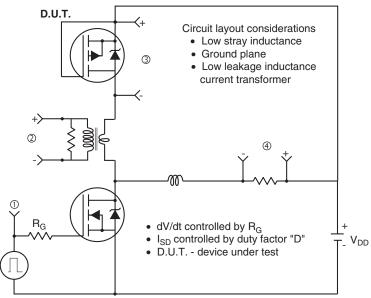


Fig. 13b - Gate Charge Test Circuit

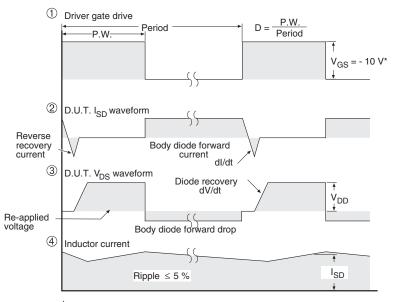




Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver



V_{GS} = - 5 V for logic level and - 3 V drive devices

Fig. 14 - For P-Channel

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